

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







Innovative Service Around the Globe

DATA SHEET

SURFACE-MOUNT CERAMIC MULTILAYER CAPACITORS

C-Array NP0/X7R/Y5V

16 V TO 50 V

sizes 0508 (4 \times 0402) / 0612 (4 \times 0603) RoHS compliant & Halogen Free



YAGEO Phícomp



SCOPE

This specification describes NP0/X7R/Y5V 4-capacitor Array with lead-free terminations.

YAGEO Phicomp

APPLICATIONS

- · Professional electronics
- · High density consumer electronics

FEATURES

- · Supplied in tape on reel
- · Nickel-barrier end termination
- 0508 (4x0402) / 0612 (4x0603) capacitors (of the same capacitance value) per array
- Less than 50% board space of an equivalent discrete component
- High volumetric efficiency
- · Increased throughout, by time saved in mounting
- · RoHS compliant
- Halogen Free compliant

ORDERING INFORMATION-GLOBAL PART NUMBER, PHYCOMP CTC & 12NC

All part numbers are identified by the series, size, tolerance, TC material, packing style, voltage, process code, termination and capacitance value. Please note that 12 digits ordering code will expire at the end of 2010.

YAGEO BRAND ordering code **GLOBAL PART NUMBER (PREFERRED)**

XXXX X X XXX X B X XXX (2) (3) (4) (5) (6) (7)

(I) SIZE - INCH BASED (METRIC)

0508 (1220)

0612 (1632)

(2) TOLERANCE

 $J = \pm 5\%$

 $K = \pm 10\%$

 $M = \pm 20\%$

Z = -20% to +80%

(3) PACKING STYLE

R = Paper/PE taping reel; Reel 7 inch

P = Paper/PE taping reel; Reel 13 inch

(4) TC MATERIAL

NPO

X5R

X7R

Y5V

(5) RATED VOLTAGE

7 = 16 V

8 = 25 V

9 = 50 V

0 = 100 V

(6) PROCESS

N = NP0

B = class 2 material

(7) CAPACITANCE VALUE

2 significant digits+number of zeros

The 3rd digit signifies the multiplying factor, and letter R is decimal point

Example: $121 = 12 \times 10^{1} = 120 \text{ pF}$



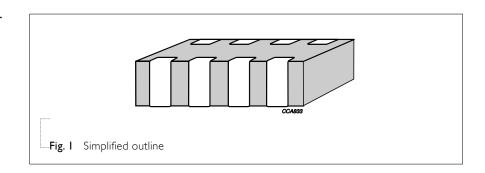
CONSTRUCTION

YAGEO Phicomp

The capacitor consists of a rectangular block of ceramic dielectric in which a number of interleaved metal electrodes are contained. This structure gives rise to a high capacitance per unit volume.

The inner electrodes are connected to the two end terminations and finally covered with a layer of plated tin (NiSn).

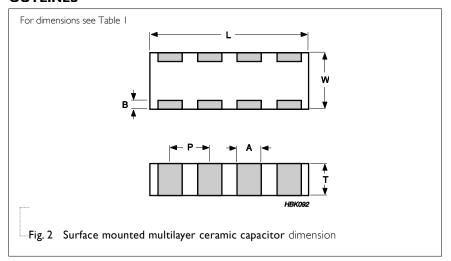
The terminations are lead-free. An outline of the structure is shown in Fig.I.



DIMENSIONS

Table I		
TYPE	0508 (4 × 0402)	0612 (4 × 0603)
L (mm)	2.0 ±0.15	3.2 ±0.15
W (mm)	1.25 ±0.15	1.60 ±0.15
$T_{min.}$ (mm)	0.50	0.70
T _{max.} (mm)	0.70	0.90
A (mm)	0.28 ±0.10	0.4 ±0.10
B (mm)	0.2 ±0.10	0.3 ±0.20
P (mm)	0.5 ±0.10	0.8 ±0.10

OUTLINES







NP0/X7R/Y5V

16 V to 50 V

CAPACITANCE RANGE & THICKNESS FOR 4C-ARRAY

Table 2 Temperature characteristic material from NP0

YAGEO Phicomp

CAPACITANCE	0508 (4 x 0402)		0612 (4 × 0603)	
	50 V	100V	50 V	100V
10 pF	0.6±0.1	0.6±0.1	0.8±0.1	0.8±0.1
15 pF	0.6±0.1	0.6±0.1	0.8±0.1	0.8±0.1
18 pF	0.6±0.1	0.6±0.1	0.8±0.1	0.8±0.1
22 pF	0.6±0.1	0.6±0.1	0.8±0.1	0.8±0.1
33 pF	0.6±0.1	0.6±0.1	0.8±0.1	0.8±0.1
39 pF	0.6±0.1	0.6±0.1	0.8±0.1	0.8±0.1
47 pF	0.6±0.1	0.6±0.1	0.8±0.1	0.8±0.1
56 pF	0.6±0.1	0.6±0.1	0.8±0.1	0.8±0.1
68 pF	0.6±0.1	0.6±0.1	0.8±0.1	0.8±0.1
82 pF	0.6±0.1	0.6±0.1	0.8±0.1	0.8±0.1
100 pF	0.6±0.1	0.6±0.1	0.8±0.1	0.8±0.1
120 pF	0.6±0.1		0.8±0.1	0.8±0.1
150 pF	0.6±0.1		0.8±0.1	0.8±0.1
180 pF	0.6±0.1		0.8±0.1	0.8±0.1
220 pF	0.6±0.1		0.8±0.1	0.8±0.1
270 pF			0.8±0.1	0.8±0.1
330 pF			0.8±0.1	0.8±0.1
390 pF			0.8±0.1	0.8±0.1
470 pF			0.8±0.1	0.8±0.1
560 pF				
680 pF				
820 pF				
1.0 nF				

NOTE

Values in shaded cells indicate thickness class in mm



16 V to 50 V

CAPACITANCE RANGE & THICKNESS FOR 4C-ARRAY

Table 3 Temperature characteristic material from X7R

YAGEO Phicomp

CAPACITANCE	0508 (4 × 0402)		0	612 (4 × 0603)			
	16 V	25 V	50 V	16 V	25 V	50 V	100V
1.0 nF	0.6±0.1	0.6±0.1	0.6±0.1	0.8±0.1	0.8±0.1	0.8±0.1	
1.2 nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1	
I.5 nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1	
1.8 nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1	
2.2 nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1	
2.7 nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1	
3.3 nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1	
3.9 nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1	
4.7 nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1	
5.6 nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1	
6.8 nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1	
8.2 nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1	
IO nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1	0.85±0.1
12 nF	0.6±0.1			0.8±0.1	0.8±0.1	0.8±0.1	0.85±0.1
15 nF	0.6±0.1			0.8±0.1	0.8±0.1	0.8±0.1	0.85±0.1
18 nF	0.6±0.1			0.8±0.1	0.8±0.1	0.8±0.1	0.85±0.1
22 nF	0.6±0.1			0.8±0.1	0.8±0.1	0.8±0.1	0.85±0.1
27 nF	0.6±0.1			0.8±0.1	0.8±0.1	0.8±0.1	
33 nF	0.6±0.1			0.8±0.1	0.8±0.1	0.8±0.1	
47 nF	0.6±0.1			0.8±0.1	0.8±0.1	0.8±0.1	
56 nF	0.6±0.1			0.8±0.1	0.8±0.1	0.8±0.1	
68 nF	0.6±0.1			0.8±0.1	0.8±0.1	0.8±0.1	
82 nF	0.6±0.1			0.8±0.1	0.8±0.1	0.8±0.1	
100 nF	0.6±0.1			0.8±0.1	0.8±0.1	0.8±0.1	
220 nF				0.8±0.1			
470 nF				0.8±0.1			

NOTE

Values in shaded cells indicate thickness class in mm



<u>6</u>

Surface-Mount Ceramic Multilayer Capacitors 4C-Array NP0/X7R/Y5V 16 V to 50 V

CAPACITANCE RANGE & THICKNESS FOR 4C-ARRAY

Table 4 Temperature characteristic material from Y5V

CAPACITANCE 0612 (4 x 0603)

25 V

10 nF	
22 nF	
47 nF	0.6±
100 nF	

NOTE

Values in shaded cells indicate thickness class in mm

THICKNESS CLASSES AND PACKING QUANTITY

Table 5				
SIZE	THICKNESS	TAPE WIDTH QUANTITY	Ø180 MM / 7 INCH	Ø180 MM / 13 INCH
CODE	CLASSIFICATION	PER REEL	Paper	Paper
0508	0.6 ±0.1 mm	8 mm	4,000	20,000
0612	0.8 ±0.1 mm	8 mm	4,000	15,000



16 V to 50 V

ELECTRICAL CHARACTERISTICS

YAGEO Phicomp

4C-ARRAY DIELECTRIC CAPACITORS; NISN TERMINATIONS

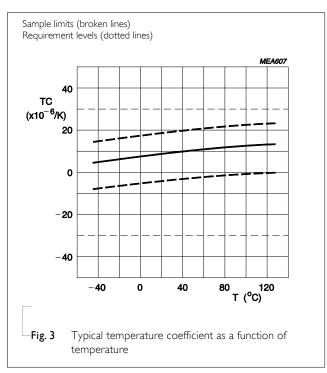
Unless otherwise stated all electrical values apply at an ambient temperature of 20±1 °C, an atmospheric pressure of 86 to 106 kPa, and a relative humidity of 63 to 67%.

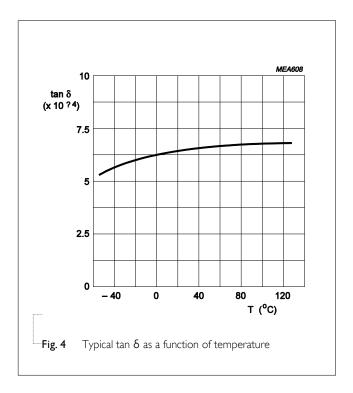
Table 6		
DESCRIPTION		VALUE
Capacitance range		10 pF to 100 nF
Rated voltage		
	NP0	50 V
	X7R	16 V to 50 V
	Y5V	0612: 25 V
Capacitance tolerance		
	NP0	±5%, ±10%
	X7R	±10%, ±20%
	Y5V	-20% to +80%
Dissipation factor (D.F.)		
	NP0	≤ 0.1%
	X7R	16 V ≤ 3.5%, 25V ≤ 2.5%, 50V ≤ 2.5%
		0508/I2nF~I00nF/I6V, Df≤5%
	Y5V	0508 ≤ 9%, 0612 ≤ 7%
Insulation resistance after I minute at U_r (DC)		$R_{ins} \ge 10~G\Omega$ or $R_{ins} \times C_r \ge 500$ seconds whichever is less
Maximum capacitance change as a function of temperature (temperature characteristic/coefficient):	ıre	
	NP0	±30 ppm/°C
	X7R	±15%
	Y5V	+22% to -82%
Operating temperature range:		
	NP0	-55 °C to +125 °C
	X7R	–55 °C to +125 °C
	Y5V	-30 °C to +85 °C

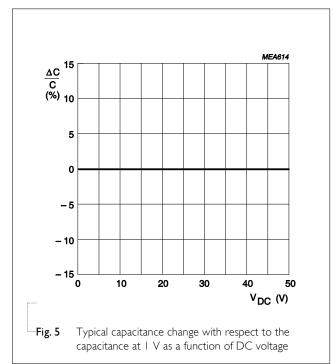


NP0/X7R/Y5V

NP0 0508/0612 50 V

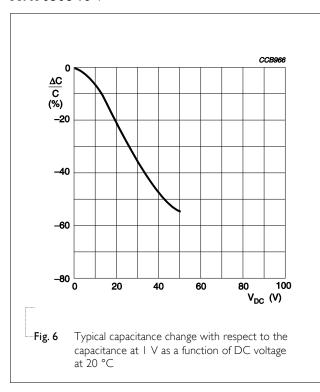


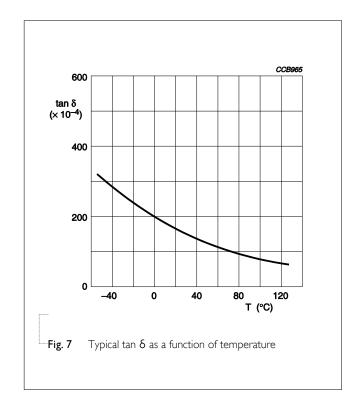


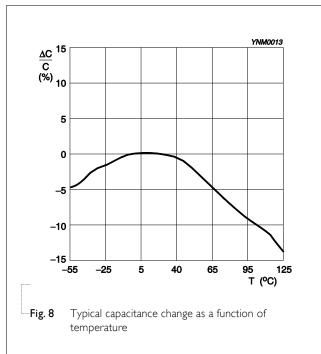




X7R 0508 16 V

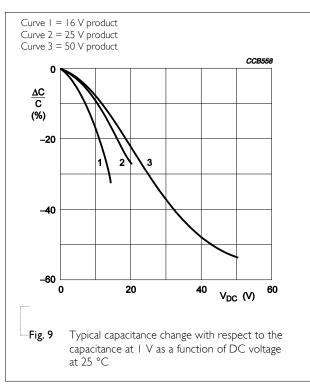


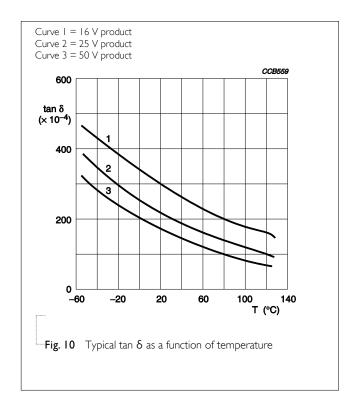


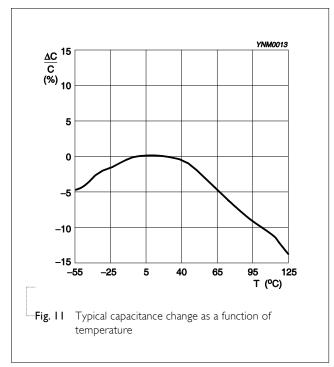




X7R 0612 16 V to 50 V



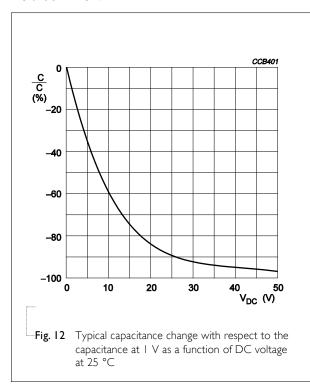


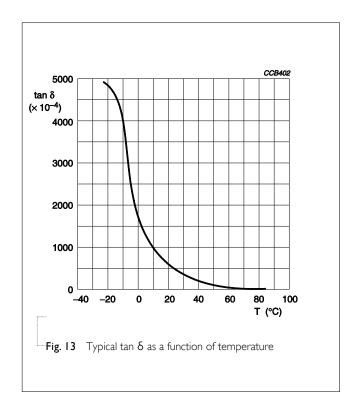


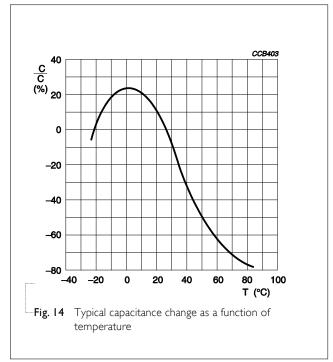


17

Y5V 0612 25 V









Surface-Mount Ceramic Multilayer Capacitors 4C-Array NP0/X7R/Y5V

TESTS AND REQUIREMENTS

Table 7 Test procedures and requirements

TEST	TEST MET	HOD	PROCEDURE	REQUIREMENTS
Mounting	IEC 60384- 21/22	4.3	The capacitors may be mounted on printed-circuit boards or ceramic substrates	No visible damage
Visual Inspection and Dimension Check		4.4	Any applicable method using × 10 magnification	In accordance with specification
Capacitance		4.5.1	Class I: $f = I \text{ MHz for C} \le I \text{ nF, measuring at voltage } I \text{ V}_{rms} \text{ at } 20 \text{ °C}$ $f = I \text{ KHz for C} > I \text{ nF, measuring at voltage } I \text{ V}_{rms} \text{ at } 20 \text{ °C}$ Class 2: $f = I \text{ KHz for C} \le I0 \mu\text{F, measuring at voltage } I \text{ V}_{rms} \text{ at } 20 \text{ °C}$ $f = I20 \text{ Hz for C} > 10 \mu\text{F, measuring at voltage } 0.5 \text{ V}_{rms} \text{ at } 20 \text{ °C}$	Within specified tolerance
Dissipation Factor (D.F.)		4.5.2	Class I: $f = I \text{ MHz for } C \leq I \text{ nF , measuring at voltage } I \text{ V}_{rms} \text{ at } 20 \text{ °C}$ $f = I \text{ KHz for } C > I \text{ nF, measuring at voltage } I \text{ V}_{rms} \text{ at } 20 \text{ °C}$ Class 2: $f = I \text{ KHz for } C \leq I0 \mu\text{F, measuring at voltage } I \text{ V}_{rms} \text{ at } 20 \text{ °C}$ $f = I20 \text{ Hz for } C > I0 \mu\text{F, measuring at voltage } 0.5 \text{ V}_{rms} \text{ at } 20 \text{ °C}$	In accordance with specification
Insulation Resistance		4.5.3	At U _r (DC) for I minute	In accordance with specification



YAGEO Phicomp

NP0/X7R/Y5V

16 V to 50 V

TEST **TEST METHOD PROCEDURE REQUIREMENTS** Capacitance shall be measured by the steps shown in the following Class I: ∆ C/C: ±30ppm **Temperature** Coefficient table. Class2: X7R: Δ C/C: $\pm 15\%$ The capacitance change should be measured after 5 min at each Y5V: Δ C/C: 22~-82% specified temperature stage. Temperature(°C) Step 25±2 Lower temperature±3°C b 25±2 С d Upper Temperature ± 2°C 25±2 е (I) Class I Temperature Coefficient shall be calculated from the formula as Temp, Coefficient = $\frac{C2 - C1}{C1 \times \Delta T} \times 10^6$ [ppm/°C] C1: Capacitance at step c C2: Capacitance at 125°C ΔT : 100°C(=125°C-25°C) (2) Class II Capacitance Change shall be calculated from the formula as below $\Delta C = \frac{C2 - C1}{C1} \times 100\%$ C1: Capacitance at step c C2: Capacitance at step b or d

Adhesion

4.7 A force applied for 10 seconds to the line joining the terminations and in a plane parallel to the substrate

Force size ≥ 0603: 5N size = 0402: 2.5Nsize = 0201: 1N

Surface-Mount	Ceramic Multil	layer Capacitors
---------------	----------------	------------------

4C-Array

NP0/X7R/Y5V

16 V to 50 V

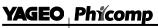
TEST	TEST METH	HOD	PROCEDURE	REQUIREMENTS
Bond Strength of	IEC 60384- 21/22	4.8	Mounting in accordance with IEC 60384-22 paragraph 4.3	No visible damage
Plating on End Face			Conditions: bending I mm at a rate of I mm/s, radius jig 5 mm	Δ C/C Class 1: NP0: within \pm 1% or 0.5 pF, whichever is greater Class2: X5R/X7R/Y5V: \pm 10%
Resistance to Soldering Heat	4.9		Precondition: I50 +0/-10 °C for I hour, then keep for 24 ±1 hours at room temperature Preheating: for size ≤ I206: I20 °C to I50 °C for I minute	Dissolution of the end face plating shall not exceed 25% of the length of the edge concerned
			Preheating: for size >1206: 100 °C to 120 °C for 1 minute and 170 °C to 200 °C for 1 minute Solder bath temperature: 260 ± 5 °C Dipping time: 10 ± 0.5 seconds Recovery time: 24 ± 2 hours	Δ C/C Class 1: NP0: within $\pm 0.5\%$ or 0.5 pF, whichever is greater Class2: \times 5R/ \times 7R: \pm 10% Y5V: \pm 20%
			-	D.F. within initial specified value R _{ins} within initial specified value
Solderability		4.10	Preheated the temperature of 80 °C to 140 °C and maintained for 30 seconds to 60 seconds.	The solder should cover over 95% of the critical area of each termination
			Test conditions for lead containing solder alloy Temperature: 235 ± 5 °C Dipping time: 2 ± 0.2 seconds Depth of immersion: 10 mm Alloy Composition: $60/40 \text{ Sn/Pb}$ Number of immersions: 1 Test conditions for leadfree containing solder alloy Temperature: 245 ± 5 °C Dipping time: 3 ± 0.3 seconds Depth of immersion: 10 mm Alloy Composition: SAC305 Number of immersions: 1	



YAGEO Phicomp

TEST	TEST METI	HOD	PROCEDURE	REQUIREMENTS
Rapid Change of	IEC 60384- 21/22	4.11	Preconditioning; I50 +0/–I0 °C for I hour, then keep for	No visual damage
Temperature			24 ±1 hours at room temperature	Δ C/C Class 1: NP0: within ±1% or 1 pF, whichever is greater
			5 cycles with following detail:30 minutes at lower category temperature30 minutes at upper category temperature	Class2: X5R/X7R: ±15% Y5V: ±20%
			Recovery time 24 ±2 hours	D.F. meet initial specified value
				R _{ins} meet initial specified value
Damp Heat with U _r Load		4.13	1. Preconditioning, class 2 only: 150 +0/-10 °C /1 hour, then keep for	No visual damage after recovery
·			24 ± I hour at room temp	ΔC/C
			2. Initial measure:	Class 1:
			Spec: refer initial spec C, D, IR	NP0: within $\pm 2\%$ or 1 pF, whichever is greater
			3. Damp heat test:	Class2:
			500 ± 12 hours at 40 ± 2 °C;	X5R/X7R: ±15%; Y5V: ±30%
			90 to 95% R.H. I.O U _r applied	D.F.
			4. Recovery: Class 1: 6 to 24 hours	Class 1: NP0: ≤ 2 × specified value
			Class 2: 24 ±2 hours	Class2:
			5. Final measure: C, D, IR	$X5R/X7R: \le 16V: \le 7\%$
			P.S. If the capacitance value is less than the minimum value permitted, then after the other measurements have been made the capacitor shall be precondition according to "IEC 60384 4.1" and then the requirement shall be met.	$\geq 25 \text{V}: \leq 5\%$ Y5V: $\leq 15\%$ R _{ins} Class 1: NP0: $\geq 2,500 \text{ M}\Omega$ or R _{ins} \times C _r $\geq 25\text{s}$ whichever is less Class2: $\times 5\text{R/X}7\text{R/Y5V}: \geq 500 \text{ M}\Omega$ or R _{ins} \times C _r $\geq 25\text{s}$ whichever is less





Surface-Mount Ceramic Multilayer Capacitors 4C-Array NP0/X7R/Y5V

TEST	TEST METHO	D	PROCEDURE	REQUIREMENTS
Endurance		4.14	1. Preconditioning, class 2 only: 150 +0/-10 °C /1 hour, then keep for 24 ±1 hour at room temp 2. Initial measure: Spec: refer initial spec C, D, IR 3. Endurance test: Temperature: NP0/X7R: 125 °C X5R/Y5V: 85 °C Specified stress voltage applied for 1,000 hours: Applied 2.0 × U _r for general product. 4. Recovery time: 24 ±2 hours 5. Final measure: C, D, IR P.S. If the capacitance value is less than the minimum value permitted, then after the other measurements have been made the capacitor shall be precondition according to "IEC 60384 4.1" and then the requirement shall be met.	No visual damage <pre> <general purpose="" series=""> $\Delta C/C$ Class I: NP0: within $\pm 2\%$ or pF, whichever is greater Class2: $\times 5R/\times 7R$: $\pm 15\%$; $\times 5V$: $\pm 30\%$ D.F. Class I: NP0: $\leq 2 \times 5$ specified value Class 2: $\times 5R/\times 7R$: $\leq 16V$: $\leq 7\%$ $\qquad \geq 25V$: $\leq 5\%$ Y5V: $\leq 15\%$ R_{ins} Class I: NP0: $\geq 4,000 \text{ M}\Omega$ or R_{ins} $\times C_r \geq 40\text{ s}$ whichever is less Class 2: $\times 5R/\times 7R/5V$: $\geq 1,000 \text{ M}\Omega$ or R_{ins} $\times C_r \geq 50\text{ s}$ whichever is less </general></pre>
Voltage Proof	IEC 60384-1 4	4.6	Specified stress voltage applied for 1 minute $U_r \le 100 \text{ V}$: series applied 2.5 U_r $100 \text{ V} < U_r \le 200 \text{ V}$ series applied (1.5 $U_r + 100$) $200 \text{ V} < U_r \le 500 \text{ V}$ series applied (1.3 $U_r + 100$) $U_r > 500 \text{ V}$: 1.3 U_r 1: 7.5 mA	No breakdown or flashover

16 V to 50 V

REVISION HISTORY

YAGEO Phicomp

REVISION	DATE	CHANGE NOTIFICATION	DESCRIPTION
Version 4	Nov. 10, 2015	-	- Product range updated
Version 3	May 21, 2014	-	- Product range updated
Version 2	Jun. 17, 2013	-	- Product range updated
Version I	Feb 05, 2010	-	- The statement of "Halogen Free" on the cover added
Version 0	Jun 22, 2009	-	- New datasheet for 4C-Array series with RoHS compliant
			- Replace from pdf files: 0508_16V to 50V_1, 0612_16V to 50V_0, C-Array_NP0_50V_0508_7, C-Array_NP0_50V_0612_7, C-Array_X7R_16V_25V_50V_0612_6, C-Array_X7R_16V_0508_5, C-Array_Y5V_25V_0508_0, C-Array_Y5V_25V_0612_5
			- Define global part number
			- Description of "Halogen Free compliant" added
			- Test method and procedure updated

